



DATASHEET APPH Specification v1.28

Signal Source Analyzer
1 MHz to 7, 26 and 40 GHz



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DEFINITIONS

- The specifications in the following pages describe the warranted performance of the instrument for $23 \pm 5^\circ\text{C}$ after a 30-minute warm-up period (unless otherwise stated).

Min/Max: Parameter range that is guaranteed by product design, and/or production tested. Warranted performance specifications include guard-bands to account for the expected statistical performance distribution, measurement uncertainties, and changes in performance due to environmental conditions.

Typical: Expected mean values, not warranted performance.

INTRODUCTION

Fully integrated cross-correlation signal source analyzer for 1 MHz to 7, 26, and 40 GHz

The APPH is an integrated solution that offers an indispensable set of measurement functions for evaluating signal sources ranging from VHF to microwave frequencies such as crystal oscillators, PLL synthesizers, clocks, phase-locked or free-running VCOs, DROs, SAW or YIG oscillators, and others.

The flexible instrument comprises a two-channel cross-correlation system with two internal tuneable reference sources and also allows measurements with externally fed references.

The APPH supports many other functions including
Absolute and residual phase noise measurements
Amplitude noise measurements
Pulsed absolute and residual phase noise measurements
Two-channel 100 MHz FFT analysis
Transient measurements (frequency, phase, amplitude vs. time)
Spectrum analysis
Frequency counter function / power meter

Additionally, the unit offers
Two programmable low noise DC supplies up to 15 V and 550 mA current capability
Three low noise tuning voltages for -5 to +20 V voltage range

It is a compact and powerful instrument available with LAN (VXI-11), USBTMC, or with GPIB (optionally) interfaces. Platform independent intuitive graphical user interface (GUI), API library, and powerful SCPI command language set is available.

Operated with an external 24 V DC supply, it consumes less than 70 W.

FACTS & FIGURES & SPECIFICATIONS

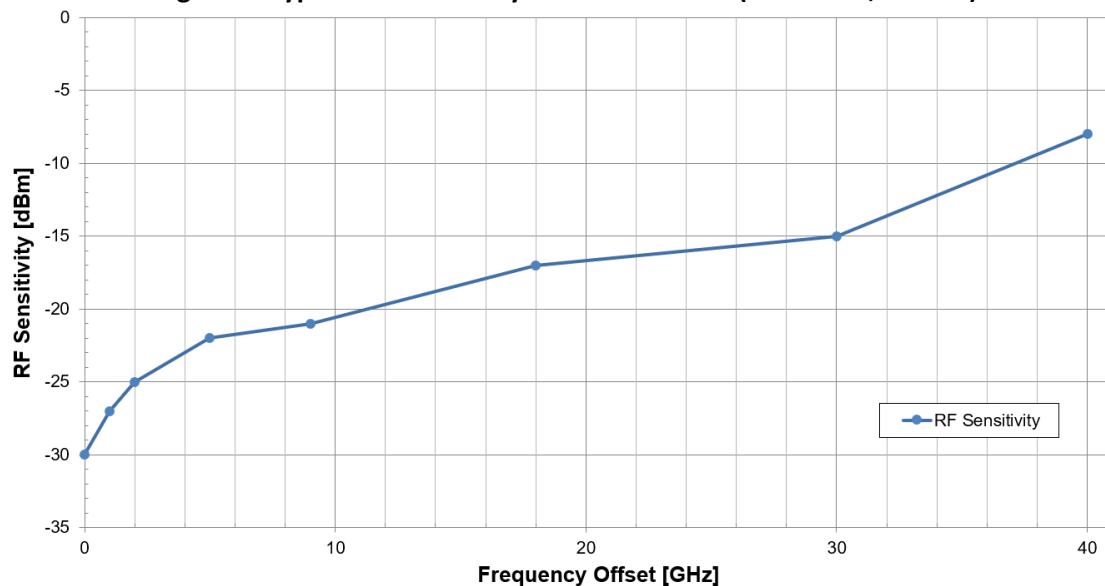
• Phase Noise Measurement Performance

Measurement parameters:

SSB Phase Noise [dBc/Hz], Spurious Noise [dBc], Integrated RMS Phase Noise Deviation [deg, rad], Time Jitter [s], Residual FM/PM [Hz RMS]

PARAMETER	MIN	TYPICAL	MAX	NOTE
RF Frequency Range	<i>FMIN</i>		<i>FMAX</i>	Using internal references
	1 MHz		7 GHz	APPH6040
	1 MHz		26 GHz	APPH20G
	1 MHz		40 GHz	APPH40G
RF Frequency Range	5 MHz		7 GHz	Using external references
	5 MHz		18 GHz	APPH6040 APPH20G / APPH40G
Input Power Range	-15 dBm		+20 dBm	Damage level +26 dBm
	-15 dBm		+23 dBm	
	-5 dBm		+23 dBm	
	< 18 GHz			
Input Impedance		50 Ω		AC coupled, 10 V DC max
	VSWR	2		
Offset Analysis Range	0.01 Hz		100 MHz	$f_c > 150 \text{ MHz}$
	0.01 Hz		> 25% of f_c	$f_c < 150 \text{ MHz}$
Resolution (PPD)	200	200	1600	RBW adjustable ($x1/x2/x4/x8$), PPD (points per decade) can be lower for lowest decade of measurement
Measurement Accuracy		±4 dB		Offset < 10 Hz
		±3 dB		Offset 10 Hz to 1 kHz
		±2 dB		Offset 1 kHz to 100 MHz
Spurious Levels				
	Internal References		-90 dBc	
Trigger			-85 dBc	
				Single, continuous, manual, bus
Frequency Counter				
	Measurement parameters: Frequency [Hz]			
RF Frequency Range	1 MHz		<i>FMAX</i>	
Absolute Accuracy		300 ppb		Or accuracy of external reference
Sensitivity				See plot "Typical RF Sensitivity"
Power Detector				
	Measurement parameters: RF Power Level [mW, dBm]			
RF Frequency Range	5 MHz		<i>FMAX</i>	APPH6040, APPH20G
Absolute Accuracy		± 1 dB	± 2.5 dB	
Power Range	- 10 dBm		+ 13 dBm	

Figure 1: Typical RF Sensitivity 5 MHz to 40 GHz (blue trace, in dBm)



Phase Noise Measurement Time

Total measurement time consists of setup time, transfer time plus the number of performed correlations times the time per correlation. The measurement times below are normalized to one correlation for nominal RBW settings per correlation and measurement times > 2 seconds.

	TIME PER CORRELATIONS	DEFAULT NR. OF POINTS (SETTABLE)
0.1 Hz to 100 MHz	80	250 per decade
1 Hz to 100 MHz	8	250 per decade
10 Hz to 100 MHz	0.8	250 per decade
100 Hz to 100 MHz	0.1	250 per decade
1 kHz to 100 MHz	0.01	250 per decade
10 kHz to 100 MHz	< 0.004	250 per decade

Absolute Phase Noise Measurements with Internal References

PARAMETER	MIN	TYPICAL	MAX	NOTE
Internal References				Cross-correlation
Frequency Range	1 MHz		FMAX	
RF Tracking Range		±1 ppm ±10 ppm ±1000 ppm		Option LN Standard High drift mode

Absolute Phase Noise Sensitivity – Internal References (Standard)

Abs. PN with internal references (Option LN)	OFFSET						
	1 Hz	10 Hz	100 Hz	1 kHz	10 kHz	100 kHz	1 MHz
10 MHz	-85	-125	-155	-165	-172	-175	-175
100 MHz	-65	-105	-135	-160	-172	-178	-178
1 GHz	-45	-85	-115	-140	-155	-160	-160
3 GHz	-35	-75	-105	-130	-145	-150	-155
10 GHz	-25	-65	-95	-120	-135	-140	-145
25 GHz	-15	-55	-85	-110	-130	-135	-140
40 GHz	-13	-53	-83	-108	-123	-133	-138
Remarks	Test conditions: carrier power $\geq 5 \text{ dBm}$; after one correlation						

Absolute Phase Noise Sensitivity – Internal References (with Option LN)

Abs. PN with internal references (Option LN)	OFFSET						
	1 Hz	10 Hz	100 Hz	1 kHz	10 kHz	100 kHz	1 MHz
10 MHz	-115	-140	-155	-165	-172	-175	-175
100 MHz	-95	-120	-135	-160	-172	-178	-178
1 GHz	-75	-100	-115	-140	-155	-160	-160
3 GHz	-65	-90	-105	-130	-145	-150	-155
10 GHz	-55	-80	-95	-120	-135	-140	-145
25 GHz	-45	-70	-85	-110	-130	-135	-140
40 GHz	-44	-68	-83	-108	-123	-133	-138
Remarks	Test conditions: carrier power $\geq 5 \text{ dBm}$; after one correlation						

Figure 2: After 1 Correlation

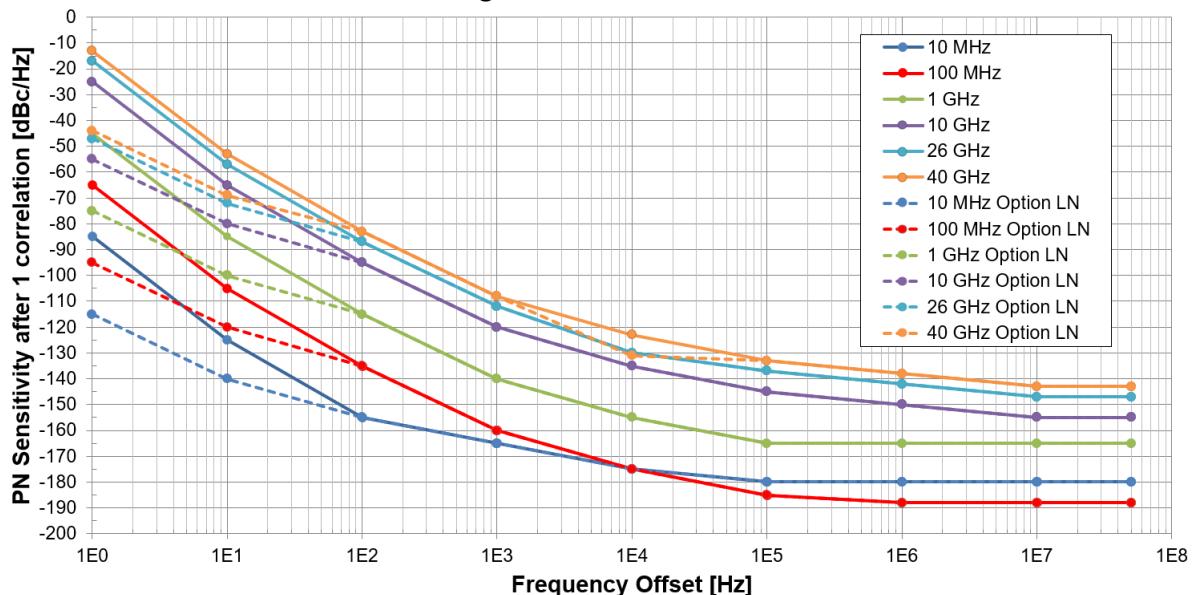


Figure 3: After 100 Correlations

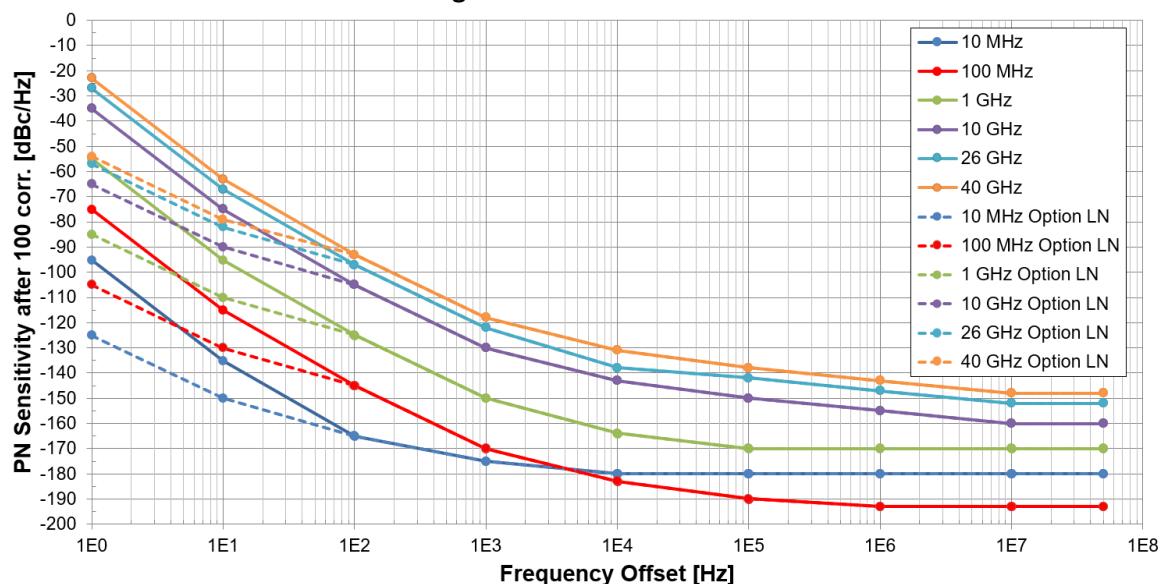


Figure 4: Phase Noise Sensitivity - High Drift

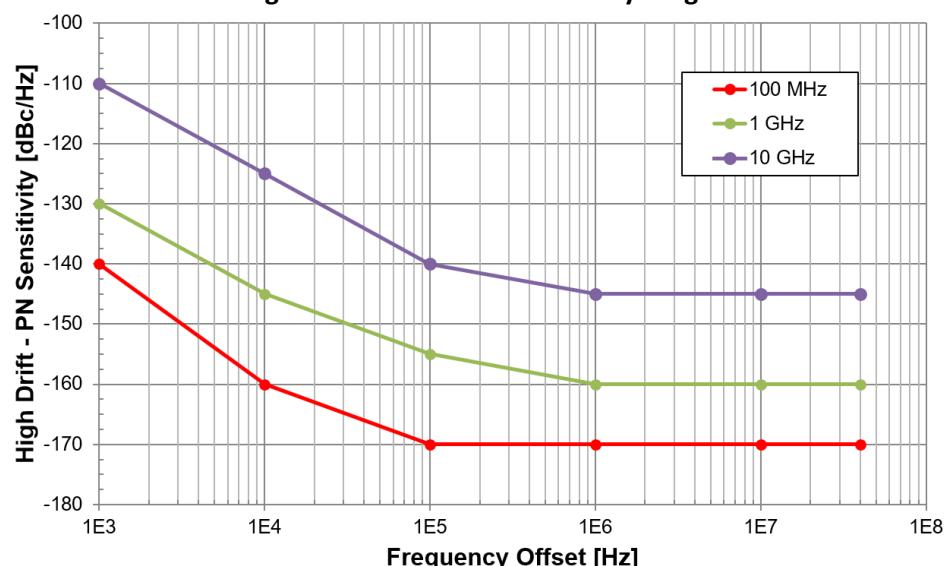
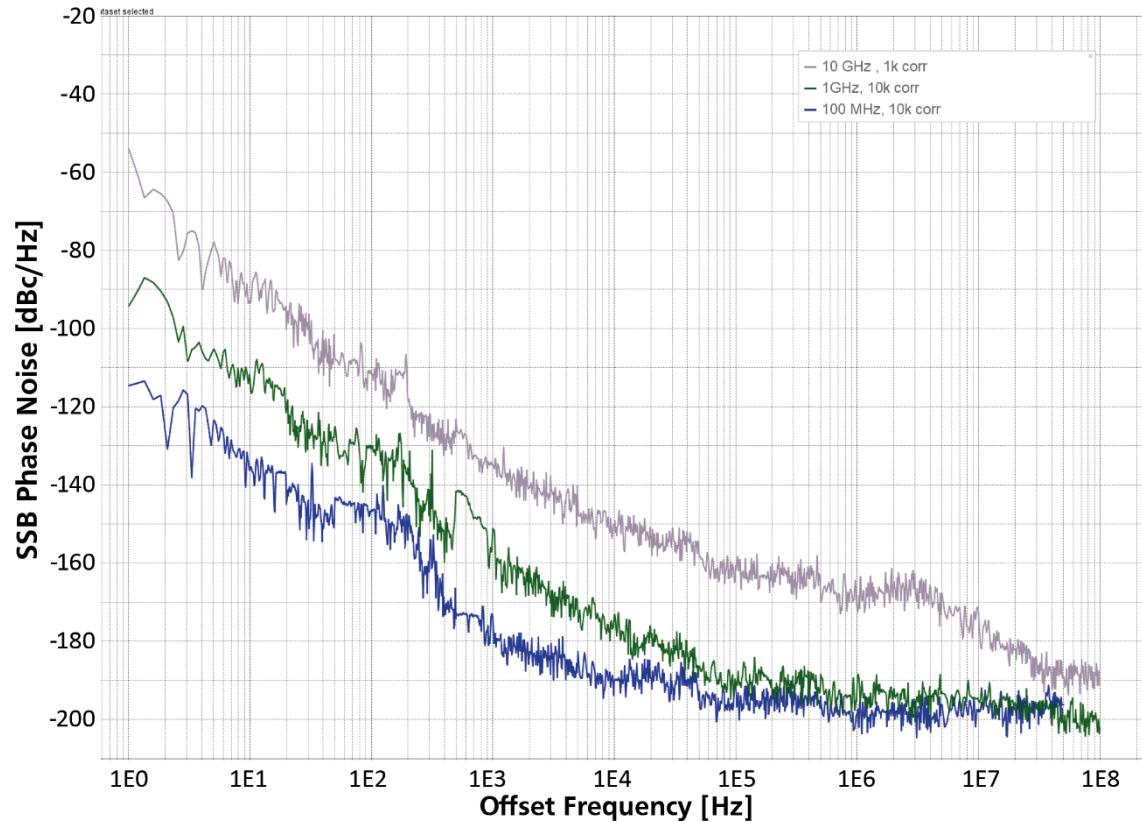


Figure 5: Typical Noisefloor Example (after > 1k correlations at 100 MHz, 1 GHz, 10 GHz)



PARAMETER	MIN	TYPICAL	MAX	NOTE
External References				single channel / cross-corr.
Frequency Range	5 MHz		7 GHz	APPH6040
	5 MHz		18 GHz	APPH20G / APPH40G
RF Input Power Range	0 dBm		+23 dBm	Damage level +26 dBm
Reference Input Level Range				
< 1.3 GHz	+10 dBm	+15 dBm	+21 dBm	Lower input ports
> 1.3 GHz	+13 dBm	+15 dBm	+21 dBm	Upper input ports
Tuning Voltage Range	-5 V		+20 V	User adjustable
Tuning Output Current			20 mA	

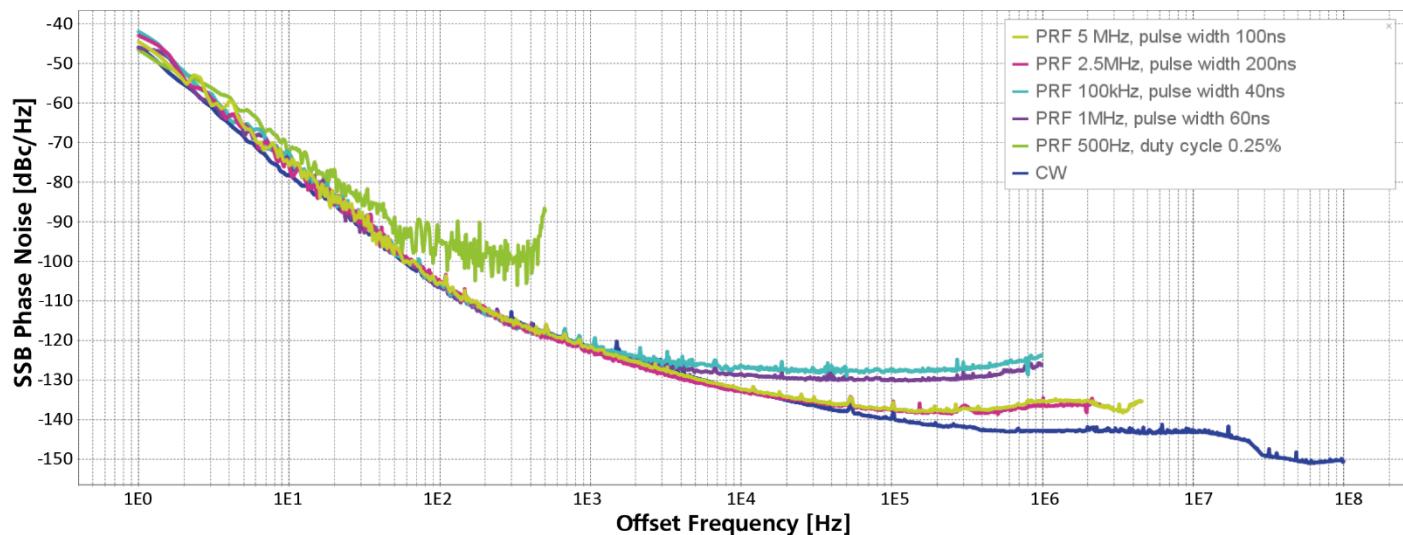
Absolute Phase Noise Sensitivity – External References

Abs. PN with external references	OFFSET						
	1 Hz	10 Hz	100 Hz	1 kHz	10 kHz	100 kHz	1 MHz
10 MHz	-135	-150	-155	-170	-175	-175	-175
100 MHz	-120	-130	-140	-170	-178	-178	-178
1 GHz	-100	-110	-125	-155	-170	-170	-170
3 GHz	-95	-110	-125	-155	-170	-170	-170
10 GHz	-90	-110	-120	-145	-155	-155	-155
18 GHz	-85	-105	-115	-130	-140	-145	-145
Remarks	Test conditions: carrier power \geq 5 dBm; after one correlation						

Absolute Phase Noise Measurement – Pulsed (Option PULSE / NPS)

PARAMETER	MIN	TYPICAL	MAX	NOTE
RF Frequency Range	30 MHz		7 GHz	APPH6040
	30 MHz		26 GHz	APPH20G
			40 GHz	APPH40G
RF Input Power Range	+5 dBm		+20 dBm	No power measurement
Input Parameters				
	Pulse Rate (PRF)	300 Hz	2 MHz	
	Pulse Width	1 µs	2 ms	Option PULSE
		50 ns	2 ms	Option NPS
	Duty Cycle	2%	60%	Option PULSE
		0.1%	60%	Option NPS
Offset Analysis Range	0.01 Hz		PRF	
Measurement Accuracy		±4 dB		Offset < 10 Hz
		±3 dB		Offset 10 Hz to 1 kHz
		±2 dB		Offset 1 kHz to 100 MHz
Measurement Time				See table "Meas. Time"

Figure 6: 3.8 GHz pulsed signals, with pulse widths \geq 40 ns and PRF \leq 5 MHz (option NFS)



Burst Mode Phase Noise Measurement (Option PULSE + Option BURST)

Measurement parameters:

SSB Phase Noise [dBc/Hz]

PARAMETER	MIN	TYPICAL	MAX	NOTE
RF Frequency Range	5 MHz		FMAX	
Offset Analysis Range	1 / T		30 MHz	
Time Span (T)	10 µs		1 min	
Phase Noise Sensitivity				Single Channel, f = 1 GHz
1 kHz		-120 dBc/Hz		
10 kHz		-128 dBc/Hz		
100 kHz		-131 dBc/Hz		
1 MHz		-131 dBc/Hz		
10 MHz		-147 dBc/Hz		

Residual (Additive) Phase Noise Measurement – CW (Option APN) and Pulsed (Option APN + PULSE)

Measurement parameters:

SSB Phase Noise [dBc/Hz], Spurious Noise [dBc], Integrated RMS Phase Noise Deviation [deg, rad]
Time Jitter [s], Residual FM/PM [Hz RMS]

PARAMETER	MIN	TYPICAL	MAX	NOTE
RF Frequency Range	10 MHz 10 MHz		7 GHz 18 GHz	APPH6040 APPH20G / APPH40G
RF Input Power Range				
RF Port	+3 dBm		+23 dBm	
REF Ports	+13 dBm		+20 dBm	
LO Output Power Range	+17 dBm		+23 dBm	Option LO
Offset Analysis Range	0.01 Hz		100 MHz	
Measurement Accuracy		±3 dB ±2 dB		Offset < 1 kHz Offset > 1 kHz

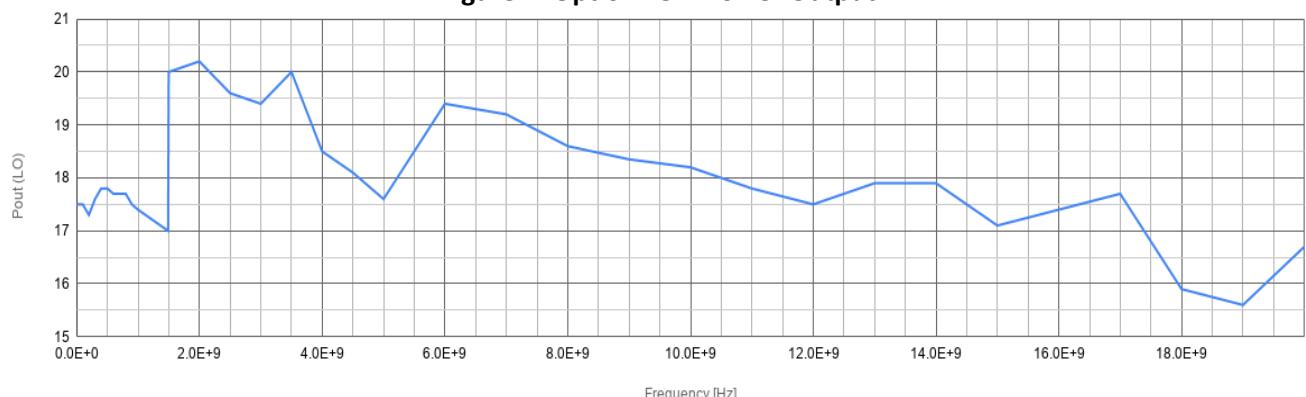
Additive Phase Noise Sensitivity – Single Channel

Additive PN (1 channel)	OFFSET						
	1 Hz	10 Hz	100 Hz	1 kHz	10 kHz	100 kHz	1 MHz
10 MHz ≤ f ≤ 1 GHz	-130	-140	-150	-160	-170	-170	-170
1 GHz ≤ f ≤ 4 GHz	-130	-140	-150	-160	-170	-170	-170
4 GHz ≤ f ≤ 16 GHz	-115	-125	-135	-145	-150	-155	-160
Remarks	Test conditions: RF carrier power ≥ 10 dBm; REF ≥ 13 dBm Two channel cross-correlation can improve noise floor by 5 dB per 10x correlations.						

LO Output (Option LO)

PARAMETER	MIN	TYPICAL	MAX	NOTE
Use: Additive Phase Noise				
Frequency Range	0 GHz		18 GHz	
Frequency Resolution		1 Hz		
Power Level	14 dBm	17.5 dBm	21 dBm	
Use: LO for Downconversion				
Frequency Range	2 GHz		20 GHz	
Frequency Resolution		0.5 GHz		
Power Level	14 dBm	17.5 dBm	21 dBm	

Figure 7: Option LO – Power Output





Absolute Amplitude Noise Measurement (Option AM)

Measurement parameters:

SSB Amplitude Noise [dBc/Hz]

PARAMETER	MIN	TYPICAL	MAX	NOTE
RF Frequency Range	5 MHz		7 GHz 26 GHz 40 GHz	APPH6040 APPH20G APPH40G
RF Input Power Range	5 MHz to 10 GHz 10 GHz to 40 GHz	-20 dBm -10 dBm	+20 dBm +20 dBm	
Offset Analysis Range	0.1 Hz		40 MHz	
Measurement Uncertainty		±2 dB		
AM Noise Sensitivity (1 corr.)				1 GHz, $P_{in} = -10 \text{ dBm}$ to +20 dBm
1 Hz		-100 dBc/Hz		
10 Hz		-115 dBc/Hz		
100 Hz		-135 dBc/Hz		
1 kHz		-145 dBc/Hz		
10 kHz		-155 dBc/Hz		
> 100 kHz		-160 dBc/Hz		



Transient Analysis (Option TRAN)

Measurement parameters:

Wideband Mode (WB): Frequency [Hz], Narrowband Mode (NB): Frequency [Hz], RF Power [dB], Phase [deg]

PARAMETER	MIN	TYPICAL	MAX	NOTE
RF Frequency Bands (WB)	5 MHz 20 MHz 80 MHz 320 MHz 1.3 GHz 5.2 GHz		100 MHz 400 MHz 1.6 GHz 3 GHz 26 GHz FMAX	Band 1 Band 2 Band 3 Band 4 Band 5 Band 6
Measurement Spans				
Wideband Mode (WB)				Bands 1-6
Narrowband Mode (NB)	200 kHz		80 MHz	200 kHz, 1.25 MHz, 80 MHz
Frequency Resolution				See table
Time Span	10 µs		1 min	
Time Resolution	16 ns		50 ms	
Trigger Mode				Single, Continuous, Internal (WB video or NB video), external

Transient Analysis – Wideband: Frequency Resolution vs. Time Resolution (residual FM, 5% video bandwidth, typical)

Frequency Measurement uncertainty is \pm (resolution + time-base uncertainty). Tabulated resolutions are measured with the APPH and DUT locked to the same 10 MHz reference. Input level 0 dBm.

Time Resolution	16 ns	128 ns	500 ns	1 μ s	\geq 10 μ s
Frequency Band	Frequency Resolution [Hz]				
5 MHz to 100 MHz	3 k	100	30	15	10
20 MHz to 400 MHz	5 k	700	200	100	20
80 MHz to 1.6 GHz	10 k	1 k	200	100	50
320 MHz to 3 GHz	30 k	1.5 k	300	150	150
1.3 GHz to 26 GHz	100 k	6 k	2 k	1 k	1 k
5.2 GHz to FMAX	500 k	20 k	4 k	2 k	2 k

Transient Analysis – Narrowband: Frequency Resolution vs. Time Resolution (residual FM, 80 MHz span, 5% video bandwidth, typical)

Frequency Measurement uncertainty is \pm (resolution + time-base uncertainty). Tabulated resolutions are measured with the APPH and DUT locked to the same 10 MHz reference. Input level 0 dBm.

Time Resolution	16 ns	128 ns	500 ns	1 μ s	10 μ s	\geq 20 μ s
Frequency Range	Frequency Resolution [Hz]					
< 200 MHz	1.5 k	50	10	4	4	4
< 800 MHz	2.5 k	150	15	10	4	4
< 2 GHz	2.5 k	500	20	10	4	4
< 20 GHz	30 k	4 k	150	70	20	7
> 20 GHz	50 k	4 k	400	150	50	15

Transient Analysis – Narrowband: Frequency Resolution vs. Time Resolution (residual FM, 1.25 MHz span, no video bandwidth, typical)

Frequency Measurement uncertainty is \pm (resolution + time-base uncertainty). Tabulated resolutions are measured with the APPH and DUT locked to the same 10 MHz reference. Input level 0 dBm.

Time Resolution	256 ns	500 ns	1 μ s	10 μ s	\geq 20 μ s
Frequency Range	Frequency Resolution [Hz]				
< 200 MHz	60	30	15	1.5	0.5
< 800 MHz	70	30	15	1.5	1.5
< 2 GHz	100	40	15	3	1.5
< 20 GHz	1 k	300	150	30	15
> 20 GHz	3 k	1 k	400	60	30

Transient Analysis – Narrowband: Frequency Resolution vs. Time Resolution (residual FM, 200 kHz span, no video bandwidth, typical)

Frequency Measurement uncertainty is \pm (resolution + time-base uncertainty). Tabulated resolutions are measured with the APPH and DUT locked to the same 10 MHz reference. Input level 0 dBm.

Time Resolution	1 μ s	10 μ s	$\geq 20 \mu$ s
Frequency Range	Frequency Resolution [Hz]		
< 200 MHz	1	0.5	0.3
< 800 MHz	1.5	0.5	0.3
< 2 GHz	3	1	0.4
< 20 GHz	20	10	3
> 20 GHz	50	20	10

• Time Stability Measurement (Option TSTAB)

Measurement parameters:

ADEV (no dead time)

PARAMETER	MIN	TYPICAL	MAX	NOTE
Measurement Time	1 s		10 days	
Resolution Bandwidth (RBW)	1 Hz	100 Hz	100 Hz	settable to 1 Hz, 100 Hz
ADEV Sensitivity				With RBW 100 Hz
$\tau = 1 \text{ s}$		5e-13		
$\tau = 100 \text{ s}$		1e-13		

• Baseband Noise Analysis

Input Connectors:

2 BNC female (rear panel), AC coupled

Measurement parameters:

Noise Spectrum [dBV/Hz, dBm/Hz, nV/VHz]

PARAMETER	MIN	TYPICAL	MAX	NOTE
Frequency Input Range	1 Hz		100 MHz	
DC Voltage Input Range	-12 V		+12 V	
Input Impedance		1 k Ω		DC
AC Voltage Range			+10 dBm	
Input Noise Density (1 correlation)				
10 kHz		< 1nV/VHz		
Trigger				Single, Continuous, Manual, Bus

Spectrum Monitoring (Option SPEC)

Measurement parameters:

Spectral Noise Density [dBm, dBm/Hz, dBv/Hz]

PARAMETER	MIN	TYPICAL	MAX	NOTE
RF Frequency Range	5 MHz		7 GHz	APPH6040
	5 MHz		26 GHz	APPH20G
	5 MHz		40 GHz	APPH40G
RBW	5.8 Hz		58 kHz	
Measurement Uncertainty				
	Absolute	±3 dB		
Relative		±1 dB		
Noise Floor				
	10 MHz to 4 GHz	-95 dBm/Hz		
	4 GHz to 18 GHz	-90 dBm/Hz		
	18 GHz to 40 GHz	-80 dBm/Hz		
Spurious (SFDR)				Spurious Free Dynamic Range
	10 MHz to 4 GHz	-70 dBc		
	4 GHz to 18 GHz	-60 dBc		
	18 GHz to 40 GHz	-55 dBc		
Trigger				Continuous

VCO Characterization (Option VCO)

Measurement parameters:

Frequency [Hz], Kvco (Tuning Sensitivity) ($\Delta f/\Delta V_c$) [Hz/V], Frequency Pushing [Hz/V], RF Power Level [dBm], DC Supply Current [mA], SSB Phase Noise [dBc/Hz]

PARAMETER	MIN	TYPICAL	MAX	NOTE
Sweep Parameters				
	DC Supply Voltage	0 V	15 V	Adjustable
	DC Supply Current		550 mA	
	Tuning Voltage	-5 V	20 V	Adjustable
Tuning Current			20 mA	
RF Frequency Range	5 MHz		FMAX	
	Uncertainty	0.5 ppm		
RF Input Power Range	-5 dBm		+20 dBm	
	Uncertainty	0.5 dB	2 dB	
DC Supply Current	0 mA		550 mA	
	Uncertainty	1%		
Output Settling Time		20 ms		
Measurement Speed		70 ms / point		Frequency, Kvco, Pushing, Supply Current, and Power

Tuning Voltage & Dual Power Supply

PARAMETER	MIN	TYPICAL	MAX	NOTE
DUT Tuning				BNC Front Panel Output
DC Voltage Range	-5 V		+22 V	
Setting Resolution		1 mV		
Setting Uncertainty		±2 mV		
Noise Level		< 2 nV _{rms} /VHz		> 2 kHz
DC Current Range	0 mA		20 mA	
DC Power Supplies				BNC Rear Panel Output (Channel 1 & 2)
DC Voltage Range	0 V		15 V	
Setting Resolution		10 mV		
Setting Accuracy		±10 mV		
Noise Level		< 10 nV _{rms} /VHz		> 20 kHz
Output Resistance		< 0.5 Ω		
DC Current Measurement Range	0 mA		550 mA	Per Channel
Resolution		100 μA		

Data Processing Capabilities

Graphical User Interface: The analyzer employs a graphical user interface based on the Windows operating system.

Display Functions	Phase Noise, Time Domain, Data Table, Residual, Statistics
Trace Functions	
Data Traces	Display current measurement and/or multiple memory data (up to 16 traces)
Title	Add customized title to each measurement window
Auto-Scale	Automatically selects scale resolution and reference value to vertically center the trace
Statistics	Calculates and displays mean, standard deviation, and peak-to-peak deviation of the trace
Marker Functions	16 independent markers

Figure 8: GUI Interface (Absolute Phase Noise)

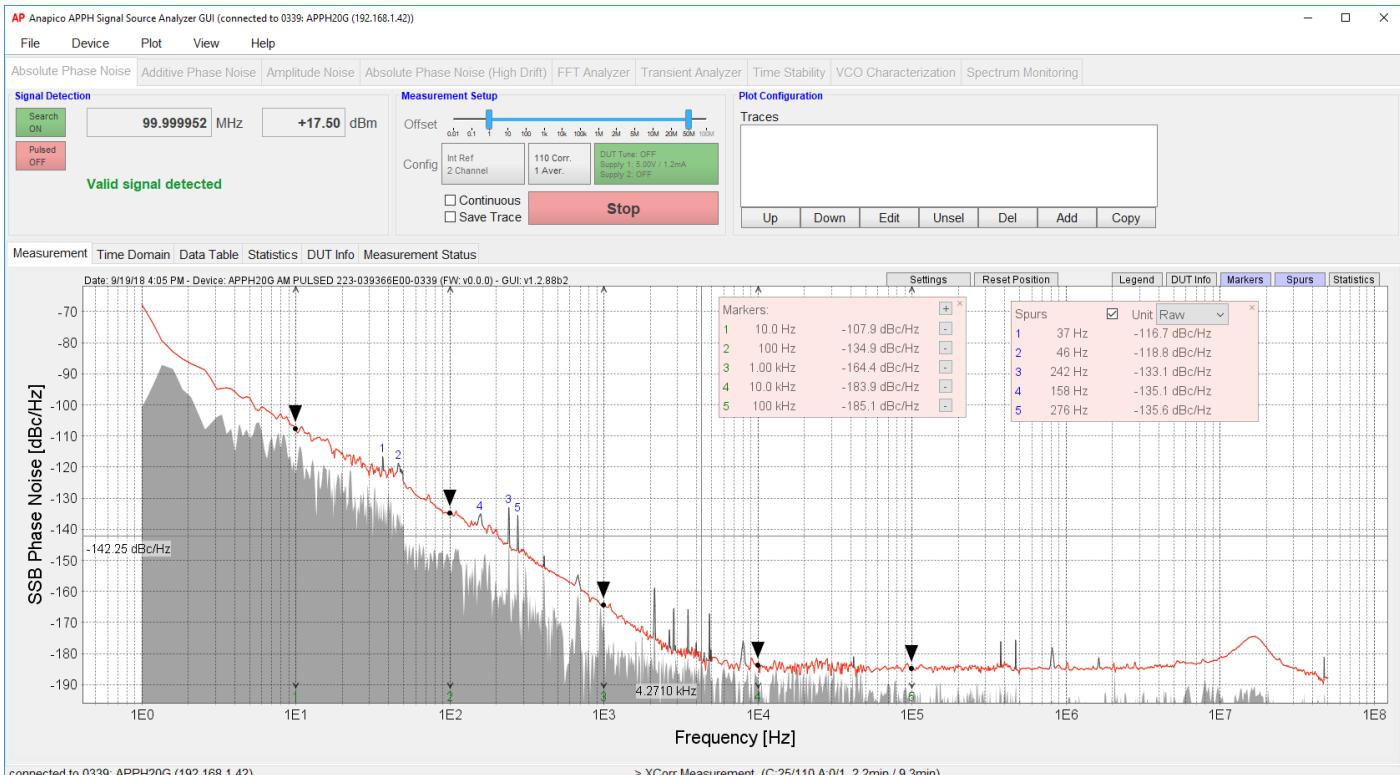


Figure 9: GUI Interface (PULSED RF Absolute Phase Noise)

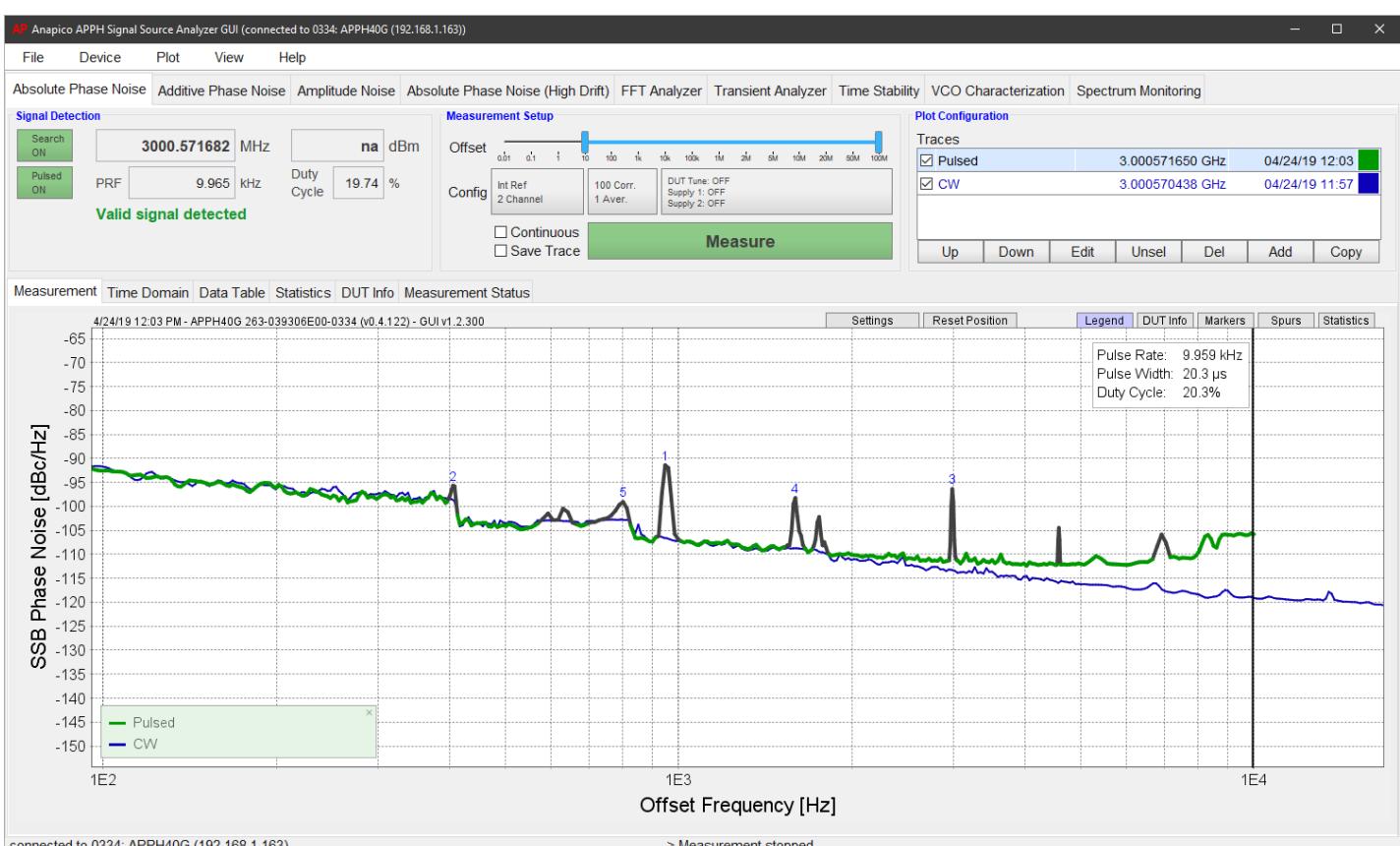


Figure 10: GUI Interface (Transient Analyzer)

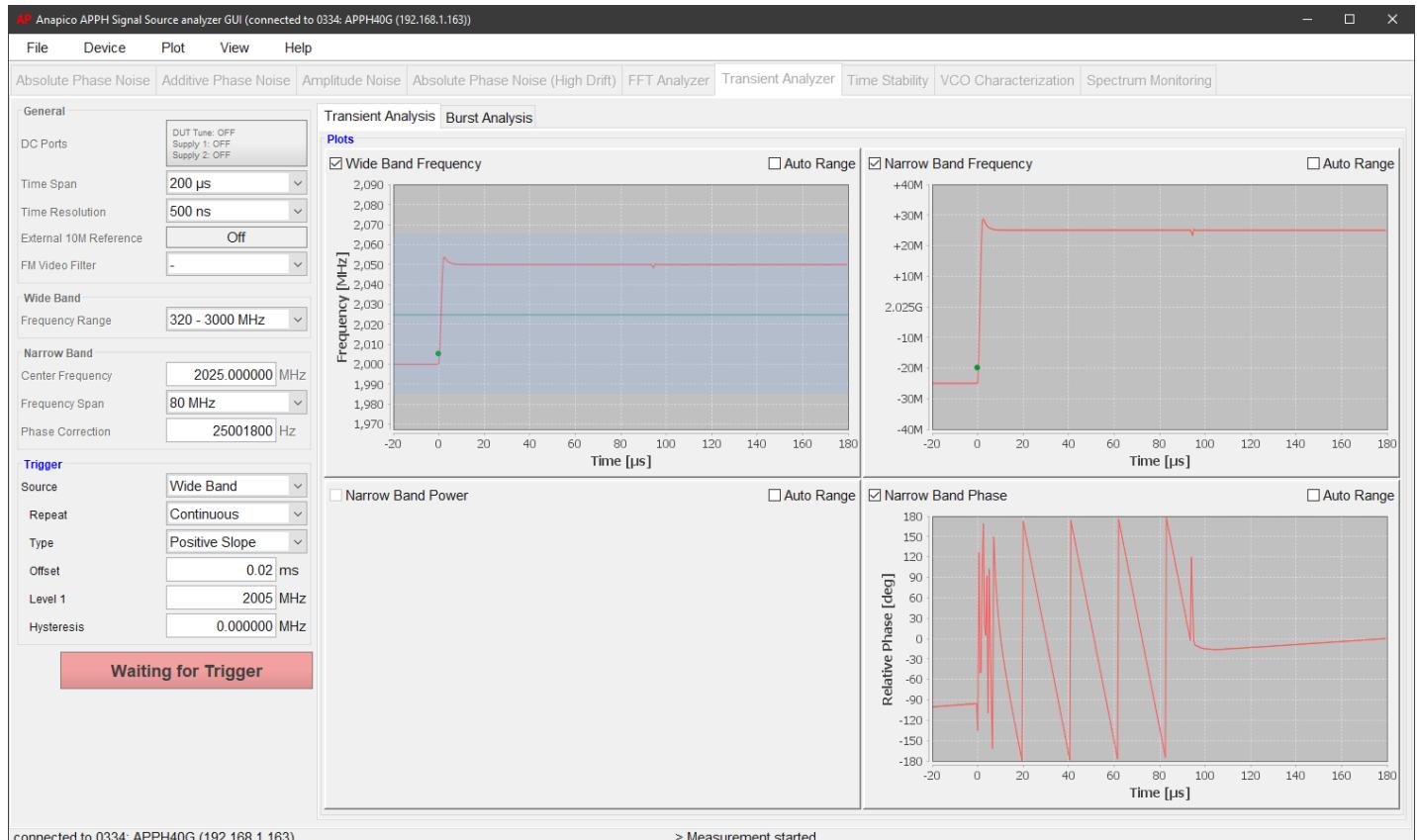


Figure 11: GUI Interface (Spectrum Monitoring)

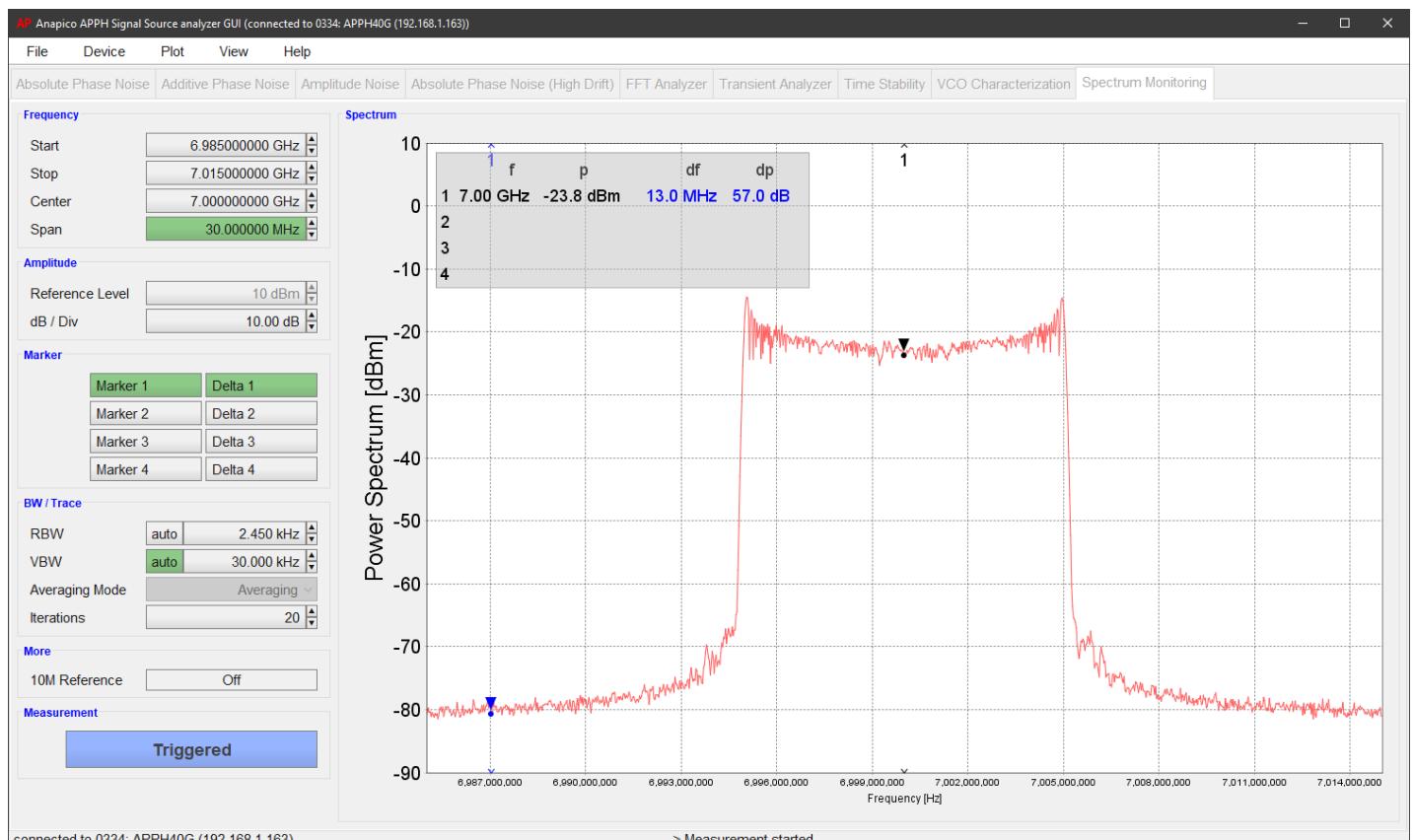
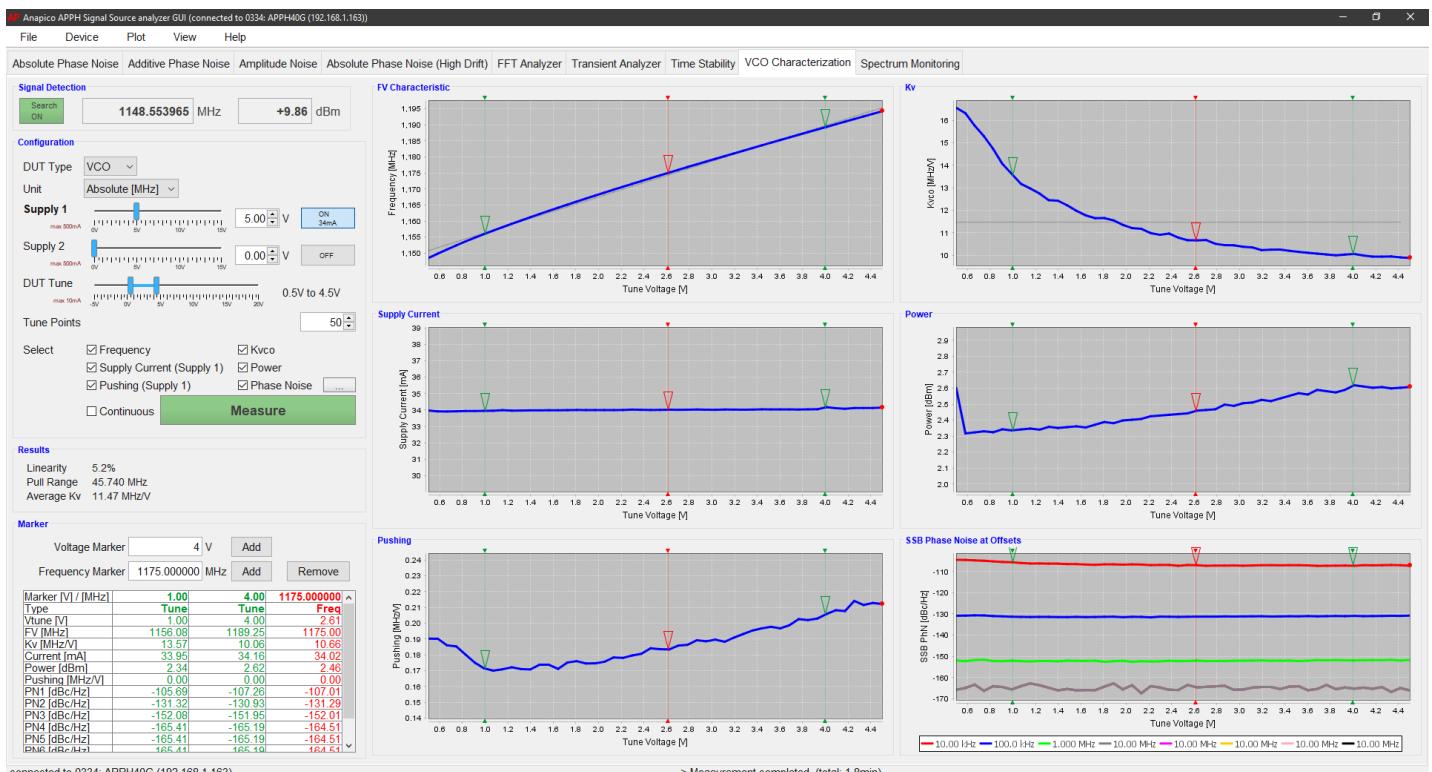
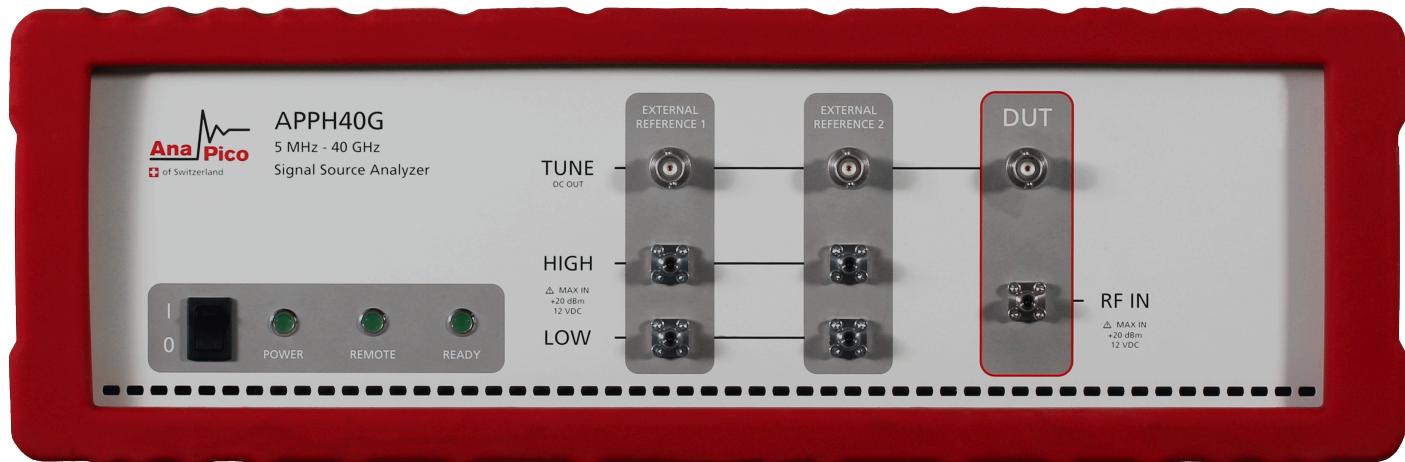


Figure 12: GUI Interface (VCO Testing)



CONNECTORS

• Connectors (Front)



RF Inputs

RF IN: SMA female (for APPH6040 / APPH20G); K female (for APPH40G)

REF1 IN HIGH/LOW, REF2 IN HIGH/LOW: SMA female

DC Outputs

REF1 TUNE, REF2 TUNE: BNC female

Operation

Switch I/O: DC Power Switch

POWER, READY, REMOTE: Status LED

• Connectors (Rear)



HF/VHF/AUX Inputs

BASEBAND CH1, BASEBAND CH2: BNC female

REF IN 10 MHz: BNC female

EXT TRIG: BNC female

DC Outputs

DC SUPPLY CH1, DC SUPPLY CH2: BNC female

Operation

LAN: RJ-45

USB B: USB 2.0 device

DC 24V: DC Power Plug (24V, 2A)

GPIB (Option GPIB): IEEE-488 GPIB Connector

Connectors (Front – Option LO)



Additional RF Inputs

LO1 IN HIGH/LOW, LO2 IN HIGH/LOW: SMA female

RF1 IN, RF2 IN: SMA female

Additional RF Outputs

LO1 OUT HIGH/LOW, LO2 OUT HIGH/LOW: SMA female

RF1 OUT, RF2 OUT: SMA female

ORDERING INFORMATION

HOST MODEL	PRODUCT	DESCRIPTION
APPH	APPH6040	Base Model: 7 GHz Signal Source Analyzer
APPH	APPH20G	Base Model: 26 GHz Signal Source Analyzer
APPH	APPH40G	Base Model: 40 GHz Signal Source Analyzer
APPH	Option LN	Ultra-low noise internal sources
APPH	Option PULSE	Pulsed signal measurement
APPH	Option NPS	Pulsed signal measurement for narrow pulses and low duty cycles
APPH	Option TRAN	Transient analysis
APPH	Option BURST	Burst mode phase noise measurement
APPH	Option AM	Amplitude noise measurement
APPH	Option APN	Additive phase noise measurement
APPH	Option LO	Access to internal reference for residual phase noise measurement (requires option APN)
APPH	Option TSTAB	Time stability analysis
APPH	Option VCO	VCO characterization
APPH	Option SPEC	Spectrum monitoring
APPH	Option GPIB	GPIB interface
APPH	Option WE	One year warranty extension (standard: 2 years)
APPH	Option ReCa	Recalibration with certificate (recommended: 2 years interval)
	Accessory APNS	Traceable AM / PN noise standard, flange-mount module
	Accessory PS06	Mechanical phase shifter 1 – 6 GHz for additive phase noise measurements
	Accessory PS18	Mechanical phase shifter 6 – 18 GHz for additive phase noise measurements

GENERAL CHARACTERISTICS

Remote programming interfaces:

Ethernet 100BaseT LAN interface
USB 2.0 device
GPIB (IEEE-488.2,1987) with listen and talk (Option GPIB)
Control Language SCPI Version 1999.0

Power requirements: 24V ± 3.0 VDC; 70 W maximum

Mains adapter supplied: 100-240 VAC in / 24 V 4.0 A DC out

Environmental: Levels similar to MIL-PRF-28800F Class 3/4



Safety / EMC complies with applicable Safety and EMC regulations and directives.

Weight: ≤ 10.0 kg (21 lbs) net

Dimensions:

incl. rubber: 154 mm H x 467.5 mm W x 342 mm L (6.1 in H x 18.4 in W x 13.5 in L)
with handle: 154 mm H x 520 mm W x 342 mm L (6.1 in H x 20.5 in W x 13.5 in L)
handle: radius 230mm (9 in); can be turned 360° in 30° steps



Document History

Version	Date	Author	Notes
V101	2017-01-20	JK	first release
V102	2017-02-20	JK	update
V111	2017-05-14	JK	updated frequency ranges, added plots
V112	2017-05-25	JK	completed RF sensitivity spec
V114	2017-06-19	JK	residual noise floor data refined
V115	2017-06-29	JK	phase noise sensitivity data added
V116	2017-07-29	JK	measurement times refined
V117	2017-08-09	JK	spectrum monitoring noise floors
V118	2018-03-20	JK	new screen shots
V121	2018-04-20	JK	reduced min RF frequency to 1 MHz; introduced additional product options
V122	2019-03-13	SD	new layout
V123	2019-05-08	SD	Added option LO
V124	2019-10-11	SD	Extended LO specification
V125	2020-09-24	SD	Added option NPS and additional tables for PN sensitivity; added LO specification
V127	2023-09-05	AP/EE	Layout changes
V128	2024-08-30	AP/YS	Added option WE and option ReCal

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